Teslameters and FP Series Hall Probes



F71 Multi-Axis Teslameter

F41 Single-Axis Teslameter

FP Series Hall Probes



F41 and F71 Teslameters

F71 Multi-axis teslameter F41 Single-axis teslameter

Perfect for measuring magnetic fields in a wide variety of applications, the new Lake Shore Cryotronics F71 and F41 teslameters with FP Series probes offer a new level of precision, convenience, and dependability.



Features

- TruZero[™] technology eliminates the need to re-zero probes
- Touchscreen interface is instantly familiar to smartphone owners
- TiltView[™] display makes the instruments easy to use whether bench- or rack-mounted
- Smaller, ultra-thin Hall sensor active areas for improved accuracy
- Multiple probe types to suit your application



Measure confidently



TruZero[™] technology eliminates errors that plague magnetic field measurements, allowing you to take measurements without probe zeroing worries



Hall probes take more accurate measurements with smaller active areas and better linearity performance than previous generation sensors



Temperature and field built in to produce field readings with great accuracy over a wide range of operating conditions

Operate easily



Uncluttered touchscreen using icons, gestures, and navigation techniques familiar to any smartphone user



The TiltView[™] display is comfortable to see and operate, providing an improved touchscreen experience



Take accurate measurements sooner with quality low-temperature coefficient electronics that eliminate warm-up times



Lightweight and durable handheld probes for quick and convenient measurements



Swap out probes fast and hassle-free with the new unified guick-release connector with built-in calibration data

Integrate conveniently



Rack-mountable, with the ability to place other similarly sized instruments next to the teslameter



Fixture-mountable probes with machined aluminum handles and alignment features for easy attachment

Both teslameters offer modern connectivity choices for seamless system integration, including:





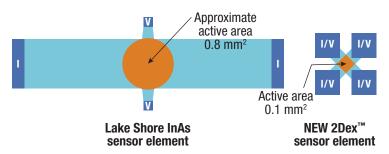


Industry standard SCPI communication library available along with LabVIEW[™] and IVI drivers.

Measure confidently

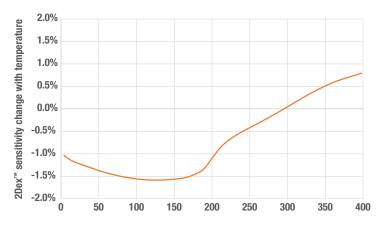
Smaller active areas

FP Series probes feature Hall sensors with significantly smaller active areas than in previous generation products. This results in improved spatial resolution and reduced signal averaging, useful when measuring fields close to a source where field gradients can be extreme.



Temperature compensation

Hall effect sensors have several characteristics that vary with temperature, resulting in Hall voltage levels that can change slightly with temperature changes. The Hall sensors used in FP Series probes are inherently stable with temperature, however, this can be improved further with active temperature compensation.



An integrated temperature sensor at the tip of every probe relays temperature data to the teslameter. These readings are used to determine temperature offsets and compensate for them over the standard workplace ambient temperature ranges.

Better 3-axis measurements

3-axis magnetic sensors have been designed to maximize orthogonality between x, y, and z sensor elements, resulting in more accurate vector magnitude measurements when field direction is unknown or changing.

Operate easily

As easy to use as your smartphone

Made for the way you work today, the F71 and F41 teslameters feature an uncluttered touch display with a unique TiltView™ screen, presenting a natural and engaging user interface.



With no confusing buttons or long learning curves, these teslameters are simple and intuitive to operate. You will quickly recognize the icons, gestures, and menu styles that follow familiar smartphone technology standards.



The large 5-inch capacitive touchscreen allows measurements to be displayed in clear, easily distinguishable fonts, making it possible to easily read in situations when your instrumentation is located some distance from where you are taking measurements.

Viewing angle is a critical parameter when interacting with a touchscreen.

Registering accurate presses can be difficult if the viewer is not aligned correctly with the screen.

TiltView[™] allows the viewer to manually adjust the viewing angle of the screen, resulting in a better view and increased accuracy when interacting with the touchscreen.

The tilt mechanism uses the perfect amount of stiffness to allow movement when desired, but stays in place when pressing and swiping on the screen.

Never zero your probe again

Offset errors in typical Hall probes occur for several reasons:

- Thermoelectric effects, which cause the offset to change with temperature.
- Imperfect contact placement geometry on the sensor, which creates so-called "misalignment voltage" errors that are harder to correct for.

These errors result in probe "drift," impacting measurement repeatability.

Typical Hall probes must be regularly placed in a **zero-gauss chamber** to zero out offsets that develop over time.



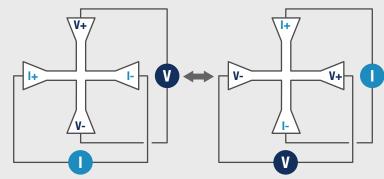
TruZero[™] technology

Lake Shore's TruZero™ technology eliminates the need to perform these frequent zeroing operations, saving time and ensuring that measurements are always accurate.

This multi-part technology is accomplished through multiple mechanisms:

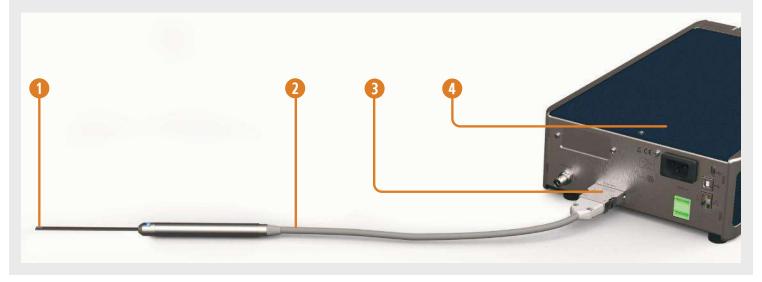
- Hall effect sensors used in FP Series probes are highly symmetrical and uniform, resulting in inherently low zero-field offset voltages.
- 2 Special insulation used in the cable for optimum dielectric performance.
- The advanced sensor excitation "spinning" technique progressively switches between different measurement configurations.
- An onboard algorithm combines the sequential Hall voltage readings in a way that eliminates any offsets due to misalignment and thermoelectric effects. This method also

reduces flicker noise, meaning that readings are both more accurate and more precise.



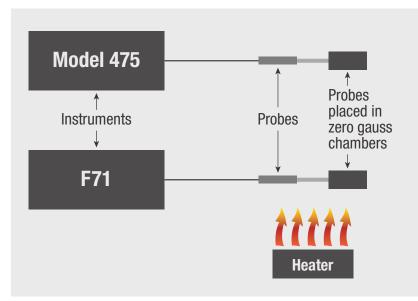
This means there is never a need to "zero" the probe before making a measurement. TruZero™ technology allows fast, worry-free, and always accurate measurements.

Note: periodic recalibration of probe and teslameter is still required to maintain an accurate conversion from Hall voltage to a field value. Not all errors can be removed completely with TruZero. Very small residual errors, much smaller than Earth field, may remain.



TruZero[™] demonstration

An experiment was conducted to observe the qualitative benefit delivered by TruZero technology.



Experiment setup

- Model 475 and F71 placed in a temperature controlled room.
- Probes placed in zero gauss chambers where magnetic field is practically zero.
- 475 zeroed at the beginning of the experiment.
- Temperature cycled over multiple hours.

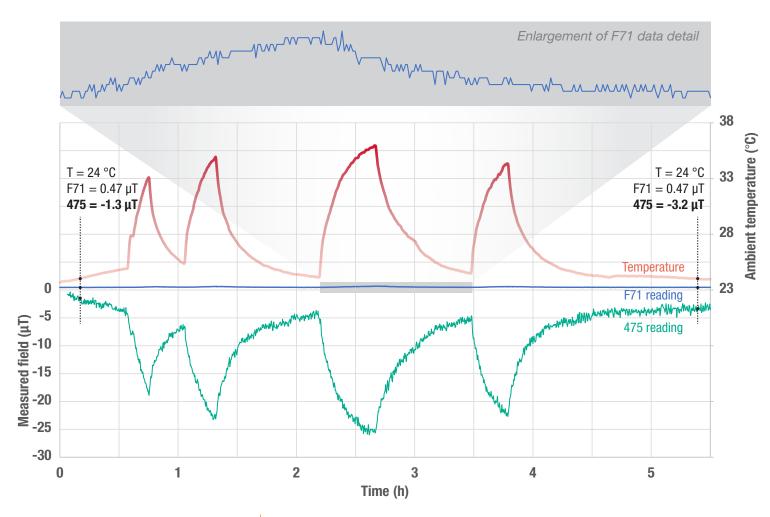
Outcomes

F71

- Very slight zero-offset drift with temperature
- No apparent drift with time
- Measurement resolution measured in nT

475

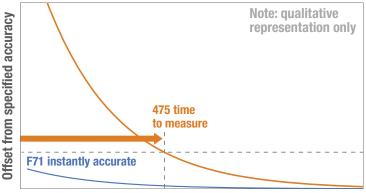
- More significant zero-offset drift with temperature
- Noticeable drift over several hours
- Measurement resolution measured in μT



Start taking measurements sooner

Lengthy warm-up times of 30 minutes or more are recommended for many teslameters and gaussmeters in order to stabilize internal temperatures.

The F71 and F41 teslameters use high-stability components with low temperature coefficients, eliminating warm-up time. Accurate readings can be taken instantly with these teslameters, removing one more variable to consider when taking field measurements.

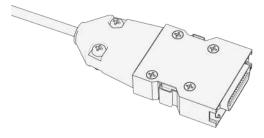


Time since instrument startup

A single connector you can use without looking

The F71 multi-axis teslameter reaches its full potential when reading a 3-axis probe, delivering full vector field measurements. Connecting a probe like this should be quick and easy, which lead us to select our new probe connector.

■ Just one connector per probe — previous implementations used separate connectors for each axis, requiring the user to pay special attention when connecting each of the 3 axes to their appropriate inputs. The new connector is used on both single and multi-axis probes, making it easier than ever to switch between probes.



New latching mechanism—allows quick and easy connection of a probe to the teslameter. The latches hold the connector securely in place without requiring thumb screws. When swapping probes, the quick-release mechanism allows you to switch probes reliably in just seconds.

Integrate conveniently

System integration

The F41 and F71 teslameter use the same 2U half-rack chassis as other Lake Shore XIP instruments, with several mounting options for standard 19-inch racks:

- Single Lake Shore XIP instrument with adjacent blank panel
- Two adjacent Lake Shore XIP instruments
- Single Lake Shore instrument next to 3rd party 2U ½ rack instrument with common mounting screws

Fixture-friendly probes

Specifically designed for scenarios where fixturing the probe is required to achieve repeatable measurements.



- Machined aluminum mounting block for a solid nondeforming surface
- Locating pin holes allow for precise alignment of the probe
- Easily held in place with just two screws
- Drawings and CAD models publicly available, making integration with your hardware quick and easy, while minimizing the risk of design error.

Probe customizations welcomed

If your application requires something different, Lake Shore may be able to design a probe to fit your exact needs. FP Series probes are all manufactured in our Ohio facility with engineering staff onsite ready to support your application. Contact your local sales representative today to start the conversation.

Teslameter specifications

Input overview

Inputs

	F41 single-axis	F71 multi-axis	
Number of measurement inputs	1	3	
Number of physical connectors	1		
Connector type	26-pin mini D-sub		
Supported probes/sensors	Single-axis probes and single-axis plug-and- play sensors	Single-axis probes and single-axis plug- and-play sensors, plus multi-axis probes	
Probes/sensors NOT supported	400 Series gaussmeter probes, and 2Dex, InAs, and GaAs loose sensors		

Ranges

•					
	Autorange	35 mT (350 G)	350 mT (3.5 kG)	3.5 T (35 kG)	35 T (350 kG)
Standard 2Dex	Yes	2 mA drive	2 mA drive	2 mA drive	0.2 mA drive
Cryogenic 2Dex	Yes	No	0.2 mA drive	0.2 mA drive	0.2 mA drive
Standard InAs	Yes	100 mA drive	100 mA drive	100 mA drive	100 mA drive
Cryogenic InAs	Yes	No	2 mA drive	2 mA drive	2 mA drive

Software features

Available measurement readings

Transis in occur on one roughly						
	Frequency range	Probe/ sensor	DC component	AC RMS	AC peak- values	Frequency
DC mode	DC only	Single- axis	Yes	_	_	_
	DG OITIY	3-axis	Yes (X, Y, Z, magnitude)	_	_	_
AC mode	DC to 550 Hz*	Single- axis	Yes	Yes	Yes	Yes
		3-axis	Yes (X, Y, Z, magnitude)	Yes (X, Y, Z, magnitude)	Yes (X, Y, Z, magnitude)	Yes (largest amplitude signal)
High frequency mode	Single-axis 1.7 Hz to 75 kHz* 3-axis		_	Yes	Yes	Yes
		3-axis	_	Yes (X, Y, Z, magnitude)	Yes (X, Y, Z, magnitude)	Yes (largest amplitude signal)

^{*}Frequency range defined as -3 dB point. See frequency specification for detailed information of instrument roll-off.

Relative values

	Single-axis probe/sensor	3-axis probe/sensor
DC mode	Field reading	Vector magnitude reading
AC mode	RMS reading	RMS of vector magnitude reading
High frequency mode	RMS reading	RMS of vector magnitude reading

Maximum hold

	DC measurement mode	AC measurement mode	High frequency mode
F41 single-axis	Field reading	RMS reading	RMS reading
F71 multi-axis	Magnitude readings	RMS reading of magnitude	RMS reading of magnitude

Maximum value Closest value to +∞ Minimum value Closest value to $-\infty$

Max hold reset Reset max and min values at the same time or separately

Performance specifications

All specifications have a minimum confidence interval of 95% with a test uncertainty ratio of 4:1. Specifications are defined as 1 year after calibration with an instrument environment within ±5 °C of calibration. Temperature coefficient of ±0.002% of rdg/°C beyond ±5 °C of instrument calibration temperature applies to all accuracy specifications. Instruments are typically calibrated at an ambient temperature of 22 °C. The exact temperature can be found through the front panel of the instrument.

DC field measurement performance

System absolute measurement accuracy

Accuracy of the reported field measurement. InAs and 2Dex sensor have identical individual axes accuracies. 3-axis magnitude accuracies are slightly better for 2Dex sensors due to reduced planar Hall effect.

Individual axes (single-axis, X, Y, Z)

	2Dex probe sensor	InAs probe sensor
Standard		
35 T (350 kG) range	±0.2% of rdg	Not yet specified
3.5 T (35 kG) range	±0.15% of rdg	±0.15% of rdg
350 mT (3.5 kG) range	±0.15% of rdg	±0.15% of rdg
35 mT (350 G) range	±0.15% of rdg	±0.15% of rdg
Cryogenic		
35 T (350 kG) range	±0.2% of rdg	Not yet specified
3.5 T (35 kG) range	±0.2% of rdg	Not yet specified
350 mT (3.5 kG) range	±0.2% of rdg	Not yet specified

3-axis magnitude accuracy

Calculated total field value based on measurement of all 3 axes.

	2Dex probe sensor	InAs probe sensor
Standard		
35 T (350 kG) range	±0.40% of rdg	Not yet specified
3.5 T (35 kG) range	±0.30% of rdg	±0.30% of rdg
350 mT (3.5 kG) range	±0.30% of rdg	±0.30% of rdg
35 mT (350 G) range	±0.30% of rdg	±0.30% of rdg
Cryogenic		
35 T (350 kG) range	±0.40% of rdg	Not yet specified
3.5 T (35 kG) range	±0.40% of rdg	Not yet specified
350 mT (3.5 kG) range	±0.40% of rdg	Not yet specified

System measurement noise

Typical RMS measurement noise at zero field (teslameter and probe both contribute to measured noise, a realistic representation of measurement performance).

	Averaging window			
	10 ms	200 ms (default)	1 s	10 s
Standard				
35 T (350 kG) range	300 μT	70 μT	30 μT	10 μT
	(3 G)	(700 mG)	(300 mG)	(100 mG)
3.5 T (35 kG) range	6 μT	1.2 μT	0.6 μT	0.17 μT
	(60 mG)	(12 mG)	(6 mG)	(1.7 mG)
350 mT (3.5 kG) range	0.7 μT	0.16 μT	0.07 μT	0.03 μT
	(7 mG)	(1.6 mG)	(0.7 mG)	(0.3 mG)
35 mT (350 G) range	0.5 μT	0.12 μT	0.05 μT	0.02 μT
	(5 mG)	(1.2 mG)	(0.5 mG)	(0.2 mG)
Cryogenic				
35 T (350 kG) range	300 μT	70 μT	0.05 μT	0.02 μT
	(3 G)	(700 mG)	(0.5 mG)	(0.2 mG)
3.5 T (35 kG) range	38 μT	8.5 μT	3.8 μT	1.2 μT
	(380 mG)	(85 mG)	(38 mG)	(12 mG)
350 mT (3.5 kG) range	4.4 μT	1 μT	0.44 μT	0.14 μT
	(44 mG)	(10 mG)	(4.4 mG)	(1.4 mG)

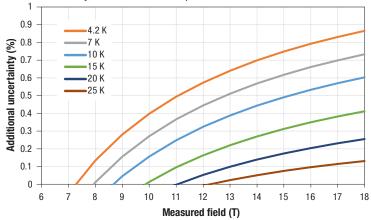
TruZero™ residual offset

Remaining detectable measurement offset (observed at zero field and expected to be present at higher fields as well)

	Individual axes (single-axis, X, Y, Z)	3-axis magnitude
Offset within ±5 °C of probe calibration temperature	±3.5 μT (±35 mG)	±7 μT (±70 mG)
Typical temperature coefficient beyond ±5 °C of probe calibration temperature	±0.3 μT/°C (±3 mG/°C)	±0.6 μT/°C (±6 mG/°C)

Quantum Hall effect additional uncertainty

When operating at high field at cryogenic temperatures, the Shubnikov-De Hass effect causes small oscillations in the effective Hall sensor sensitivity. The following plot outlines the additional uncertainty values that should be expected.

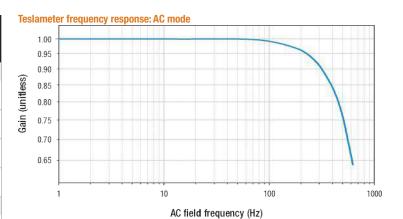


AC field measurement performance

AC mode bandwidth

AC mode cut-off frequency

550 Hz (-3 dB) 60 Hz (-0.2%)



AC mode accuracy

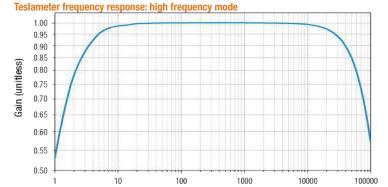
Accuracy of the reported field measurement at frequencies within the flat response portion of the instrument frequency response curve.

	Individual axes (single-axis, X, Y, Z)	3-axis magnitude
RMS	±0.25% of reading ±0.05% of range	±0.5% of reading ±0.1% of range
Peak to peak	±0.55% of reading ±0.2% of range	Reading not present on instrument

High frequency mode measurement performance

High frequency mode passband

1.7 Hz to 75 kHz (-3 dB point) 20 Hz to 7 kHz (-0.2%)



High frequency mode accuracy

Accuracy of the reported field measurement at frequencies within the flat response portion of the instrument frequency response curve.

AC field frequency (Hz)

	Individual axes (single-axis, X, Y, Z)	3-axis magnitude
RMS	$\pm 0.5\%$ of reading $\pm 0.5\%$ of range	±1% of reading ±1% of range
Peak to peak	±2% of reading ±2% of range	Reading not present on instrument

Frequency detection

Frequency detection counter accuracy:

 $\pm 1\%$ of frequency ± 1 Hz for a periodic wave faster than 1 Hz and RMS value greater than 1% of range

Temperature compensation

Temperature compensation of field

Sensor/probe temperature-dependent field measurement error — we have characterized the temperature dependence of sensitivity for our Hall sensors and apply a correction factor to compensate. The residual error listed below reflects the variability that exists from sensor to sensor.

	Temperature range			
	-273 °C to 0 °C to 35 °C to 60 °C to 90 °C			
Compensation: on	±1.5%	±0.02%	±0.1%	±0.5%

Temperature compensation sources: Embedded probe sensor, manual entry (front panel), manual entry (external communication), none

(compensation off)

Temperature compensation range:

Probe dependent (see probe specifications

for details)

Analog output

	Mode	Function	Channels/readings available (non-concurrent)
Raw	DC	Diagnostic only	X, Y, Z
modes	AC	Diagnostic only	X, Y, Z
	High frequency	Analog representation of waveform (pulse, etc.)	X, Y, Z
Corrected modes	DC	Analog representation of field values	X, Y, Z, vector magnitude
	AC	Analog representation of RMS field values	X, Y, Z, vector magnitude
	High frequency	Analog representation of RMS field values	X, Y, Z, vector magnitude

Limits: ±12.5 V possible during overload Analog amplified Hall voltage Raw signal source:

Raw signal accuracy: ±1% of amplified Hall voltage value ±50 mV DAC generated voltage based on field reading **Corrected output source:**

Corrected output range: $\pm 3.5 V = full range$

Corrected output accuracy: ±1% of front panel measurement

Corrected output update rate: 2 kHz

Field control option card

Control types: Closed loop (PI) or open loop

Closed loop control technology: Proprietary composite DAC, ensures control circuit does

not limit resolution

Setpoint, setpoint ramping Features:

Full scale voltage output: ±10 V

Control resolution: <0.1 uT (<1 mG)*

Configurable maximum slew rate, configurable voltage Protections:

Open loop voltage accuracy: ±1% of full scale

* Specified value applies for the 350 mT range with 10 second averaging. Specification limited by measurement noise. Control resolution for a particular configuration is double the specified system noise.

Digital I/O

Number of independent inputs Input isolation **Optical** Maximum low-level input voltage Minimum high-level input voltage 4 V Safe input voltage rage -5 V to 35 V

Number of relays Relay type Solid state Digital output relay maximum current 2 A Digital output relay maximum voltage 35 V

Environment

Instrument operating environment

23 °C ±5 °C and <70% relative humidity noncondensing at rated accuracy; -20 °C to 70 °C and <90% relative humidity non-condensing at

reduced accuracy

Instrument max field exposure

10 mT (100 G) DC, 1 mT (10 G) RMS

Communication

Protocols

Each protocol is supported on all interfaces.

	Function	
SCPI commands Native communication method with instrum		
Python driver	Simplifies connection and operation with Python	
LabVIEW™ driver	Add teslameter to LabVIEW [™] -controlled systems	
IVI.NET driver	Easier integration with test and measure instruments	

Type USB 3.0, mass storage class (MSC) device **Function** Firmware updates, flash drive support

Location Rear panel

C-type USB connector Connector

USB device

USB 2.0 Type

Function Emulates a standard RS-232 serial port

Standard commands for programmable instruments (SCPI) Protocol

Baud rate 115,200

Connector B-type USB connector

Software support LabVIEW[™] and IVI.NET drivers (see www.lakeshore.com)

Function TCP/IP command and control, mobile app (in development) App layer protocol Standard commands for programmable instruments (SCPI) Connector **RJ-45**

Speed 1 Gb/s

LabVIEW™ and IVI.NET drivers (see www.lakeshore.com) Software support

Display

Display update rate 5 rdq/s

Display 5 in capacitive touch, color 800 × 480 with LED backlight

General

Operating conditions

23 °C ±5 °C, <70% relative humidity noncondensing at rated accuracy; -20 °C to 70 °C, <90% relative humidity non-condensing at

reduced accuracy

100 V to 240 V (universal input), 50 to 60 Hz, 30 VA Power requirement Size 217 mm W \times 87 mm H \times 317 mm D (8.5 in \times 3.4 in

× 14.5 in), half rack

Weight 3.2 kg (7 lb) **Approval** CE mark Warm-up time Ready on boot **Power consumption** 35 W maximum

Ordering information

F41/F71 teslameters

F41 single-axis teslameter F41 F71 F71 multi-axis teslameter

Accessories

MR-GPIB-USB GPIB to USB adapter for XIP instruments F41 teslameter recalibration with certificate CAL-F41-CERT CAL-F41-DATA F41 teslameter recalibration with certificate and data CAL-F71-CERT F71 teslameter recalibration with certificate

CAL-F71-DATA F71 teslameter recalibration with certificate and data

FP Series Hall probes

Features

■ Wide field range—suited for everything from earth-field to the world's strongest electromagnets

Hall sensors with tiny active area of just 0.1 mm² for more precise measurements

Temperature and linearity (field) compensation are built-in

Versatile handle and stem options to suit numerous applications

Ease of use features such as active area and polarity indicators

Application-specific probe customization available



FP Series probes make it easier than ever to integrate magnetic field measurement into your system. Take advantage of probes and sensors that really fit your application for optimum measurement results.

Lake Shore offers probes for every need, including 3-axis (vector) and transverse models available in both handheld and fixture-mountable versions.

If your application is unique, Lake Shore may be able to design a probe to fit your exact needs. FP Series probes are all manufactured in our Ohio facility with engineering staff on site ready to support your application. Contact your local sales representative today to start the conversation.

FP Series probe availability

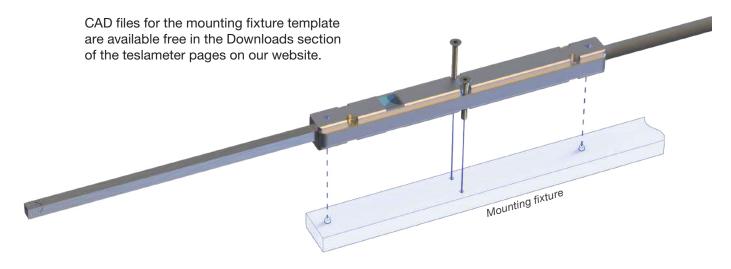
Transverse				highlighted in yellow	
Stem type	Stem material	Stem size	Form factor	Stem Lengths (cm)	Part number
Standard	Aluminum	1.55 × 4.57 mm	Handheld	5 15 30 —	FP-NS-180-TSXX
Stanuaru	Alullillulli	1.55 × 4.57 IIIII	Mountable	5 15 30 —	FP-NS-180-TSXXM

Stock probes

3-axis

Stem type	Stem material	Stem size	Form factor	Ste	m Len	gths (cm)	Part number
Standard	Aluminum	4 × 4 mm	Handheld	5	15	30 —	FP-NS-180-ZSXX
	Alullillulli	4 × 4 111111	Mountable	5	15	30 —	FP-NS-180-ZSXXM

The mountable handle has locating pin holes for precise and repeatable probe alignment.



Probe configuration options

Customize your probe using the range of available options to match your application.

FP-aa-bbb-cdee(f)(-gg)

Sensor

NS-180 InAs

Orientation

Z 3-axis

Stem type

Standard

Stem length

05	5 cm (2 in)	
15	15 cm (6 in)	
30	30 cm (12 in)	
150	150 cm (60 in)	

Special handle (optional)

Handheld (default)	
M	Mountable

Additional cable length (optional)

	2 m (6 ft) (default)	
6	6 m (20 ft)	
15	15 m (50 ft)	

Sensor

NS-180 InAs

InAs sensors are currently the only sensor type currently available with FP Series probes. These probes offer a great balance of sensitivity, linearity, stability and ruggedness.

Orientation

Hall sensors are inherently directional, so the anticipated field direction will guide the selection of probe orientation.

Z 3-axis

Multiple sensors are placed to measure three orthogonal field vectors, allowing the measurement of both the overall field value and direction. This is particularly useful in several scenarios:

- Complex fields where the field direction is not known or changing over time
- Quick handheld measurements
- Field mapping of a volume

The three individual sensors don't occupy the exact same location, meaning the three separate measurements are for slightly different positions in space. This results in the specification of an active volume, as opposed to an active area for single-axis probe variants. These probes can be identified by their square stem cross-section.

3-axis probes are only available with a standard stem up to 30 cm in length.

Transverse (single-axis)

The sensor is positioned to measure fields running perpendicularly through the probe stem. This is most useful for measuring fields inside magnet gaps. These probes are easily identified by their flattened rectangular stem.

Stem type

The sensor/s are housed in stem types suited for various applications. Where possible, active area locations are marked on the stems.

S Standard

The general-purpose stem options offer an excellent balance of size and strength. Constructed from extruded and precision machined aluminum, these stems will be the superior choice in most situations.

Stem length

FP Series probes come in various lengths to suit your application.

	5 cm (~2 in)	15 cm (~6 in)	30 cm (~12 in)	150 cm (~60 in)
	05	15	30	150
Standard				

If your application requires a non-standard stem solution, please contact us to discuss options.

Special handle (optional)

Both handle options include polarity indicators when ordered with a transverse orientation, making it easy to quickly determine whether a magnet polarity has been switched, or if the probe is just being held incorrectly.



The default handle configuration is deigned to be a comfortable and functional handheld solution with an anodized aluminum grip for a solid and long-lasting grip surface.



In situations where probe fixturing is required to achieve repeatable measurements, the mountable form factor features a flat machined aluminum surface. It also includes locating pinholes for precise probe alignment and is easily held in place with just two screws.

Publicly available drawings and CAD models for this handle will make integration with your hardware quick and easy while minimizing the risk of a design error. These handles are available with standard and flexible stem choices.

Additional cable length (optional)

2 m (6 ft)	6 m (15 ft)	15 m (50 ft)
	6	15

The probe cable and connector have also received close attention to optimize performance and usability. The shielded cable was selected to be as thin and light as possible, while using a special insulation that is both recyclable and forms a part of the TruZero™ technology that allows the probes to operate without needing to zero.

The connector makes use of the compact Micro-D standard to support all connections required for a 3-axis probe in a reasonably sized package. Both single and multi-axis probes use this connector, so there is no need to pay special attention to making individual axis connections as is the case for other multi-connector solutions. A user-friendly latching mechanism means swapping probes is fast and trouble free and can be accomplished in just a few seconds.

Calibration data for the probe is stored inside the connector, allowing for fast and simple probe swapping. The teslameter configures itself automatically each time a probe is connected.

Most probes come with a 2 m (6 ft) cable by default, but can be customized with either a 6 m (20 ft) or 15 m (50 ft) cable. This is particularly useful for very large fields, as the teslameter unit itself should not be exposed to strong fields.

FP Series probe specifications

Sensor type

	Sensor	Description	Active area
NS-180*	InAs	Standard sensor	0.1 mm ²

^{*2}Dex production is currently paused

Temperature compensation

	Built-in thermistor	Temperature range
Standard	Yes	0 °C to 90 °C

Stem material

	3-axis	Transverse
Standard		Anodized aluminum tube with a
	Anodized aluminum tube with a	1.55 mm maximum thickness by
	4 mm square cross section	4.57 ±0.20 mm rectangular cross
		section

Stem length: Distance from tip of sensor to beginning of handle

Stem operating temperature range

	3-axis	Transverse
Standard	0 °C to 90 °C	0 °C to 90 °C

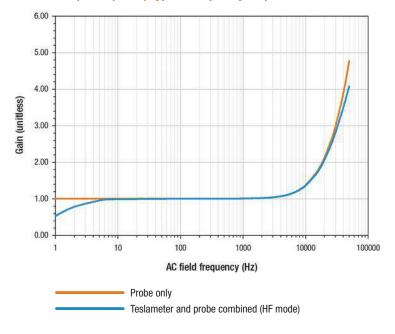
Handle

	Handheld (default)	Mountable
Length, including strain relief	138 mm	110 mm
Diameter	13 mm	NA
Thickness	NA	10 mm
Width	NA	12 mm
Material	ABS/polycarbonate blend with anodized aluminum grip	Machined aluminum with brass screws. Mountable to fixture using customer supplied M2 screws with 3.8 mm diameter socket head and 2 mm diameter alignment pins
Operating temperature range	0 °C to 80 °C	0 °C to 80 °C

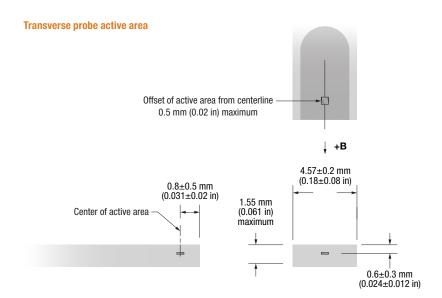
Cable

	Single-axis	3-axis	
Diameter	4 mm (0.17 in)	5.2 mm (0.21 in)	
Bend radius	40 mm (1.57 in)	52 mm (2.05 in)	
Operating temperature range	-40 °C to 80 °C		
Conductors	4 twisted-pair	14 twisted-pair	
Cable shield	100%-coverage foil	100%-coverage foil	
Cable insulation	Modified polyphenylene ether		
Connector	26-pin Mini-D with quick-release latch		

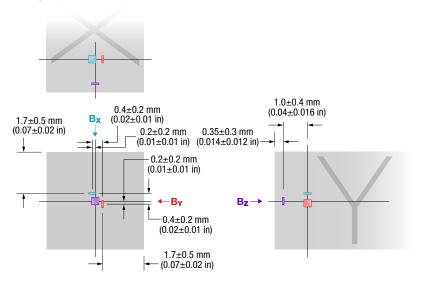
Transverse probe (TSXX) typical frequency response



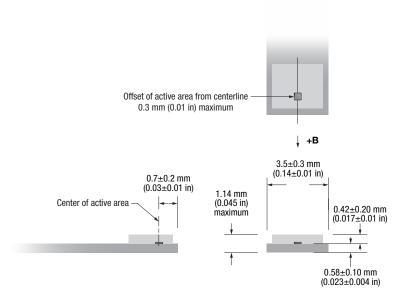
Probe active areas



3-axis probe active area



Flexible probe active area



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Questions? Answers?

Visit http://forums.lakeshore.com/ and become part of the conversation!



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